

Technology Center 2800 Semiconductor Customer Partnership Meeting

July 26, 2018

8:30-9:00am	Coffee and Networking		
9:00-9:05am	Welcome	Andy Faile, Deputy Commissioner for Patent Operations	
9:05-9:30am	Opening Remarks	Joseph Thomas, Technology Center 2800 Director	
9:30-10:25am	Patent Quality Cooperation – OPQA & TC Operations Quality	Sandie Spyrou, Supervisory Review Quality Assurance Specialist and TC 2800 Quality Lead Brian Sircus, Management Quality Assurance Specialist	
10:25-10:45am	Break and Transition to Breakout Sessions		
10:45am-12:00pm	Breakout Session I: Appeals and Pre-Appeals Processes	Alexander Sofocleous, Supervisory Patent Examiner Brian Sircus, MQAS	Madison South Auditorium
	Breakout Session II: Certainty in Search and CPC	Brett Feeney, Supervisory Patent Examiner Kevin Parendo, TC Trainer and CPC Quality Nominee	Knox Conference Center
	Breakout Session III: Interview Tools and Processes	William Kraig, Supervisory Patent Examiner Jun Jeong (Jun) Park, IP&T Group LLP	Randolph Conference Center

12:00-1:00pm	Lunch on Own	
1:00-1:30pm	Factors Affecting the Value of Semiconductor Patents	Raj Gupta, Ph.D., Finnegan, Henderson, Farabow, Garrett & Dunner LLP
1:30-1:40pm	Break	
1:40-2:50pm	PTO Panel: Continuing the Conversation	<p>Sandie Spyrou, Supervisory Review Quality Assurance Specialist and TC 2800 Quality Lead</p> <p>Brian Sircus, Management Quality Assurance Specialist</p> <p>Brett Feeney, Supervisory Patent Examiner</p> <p>William Kraig, Supervisory Patent Examiner</p> <p>Alexander Sofocleous, Supervisory Patent Examiner</p> <p>Davienne Monbleau (Moderator), Supervisory Patent Examiner</p>
2:50-3:00pm	Closing Remarks	Joseph Thomas, TC 2800 Director